

# International IR Rectifier

AUTOMOTIVE MOSFET

PD - 95467

**IRF3808SPbF**

**IRF3808LPbF**

HEXFET® Power MOSFET

## Typical Applications

- Integrated Starter Alternator
- 42 Volts Automotive Electrical Systems
- Lead-Free

## Benefits

- Advanced Process Technology
- Ultra Low On-Resistance
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax

## Description

Designed specifically for Automotive applications, this Advanced Planar Stripe HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this HEXFET power MOSFET are a 175°C junction operating temperature, low R<sub>θJC</sub>, fast switching speed and improved repetitive avalanche rating. This combination makes the design an extremely efficient and reliable choice for use in higher power Automotive electronic systems and a wide variety of other applications.

## Absolute Maximum Ratings

	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	106@	A
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	75@	
I <sub>DM</sub>	Pulsed Drain Current ①	550	
P <sub>D</sub> @ T <sub>C</sub> = 25°C	Power Dissipation	200	W
	Linear Derating Factor	1.3	W/°C
V <sub>GS</sub>	Gate-to-Source Voltage	± 20	V
E <sub>AS</sub>	Single Pulse Avalanche Energy ②	430	mJ
I <sub>AR</sub>	Avalanche Current ③	82	A
E <sub>AR</sub>	Repetitive Avalanche Energy ④	See Fig.12a, 12b, 15, 16	mJ
dv/dt	Peak Diode Recovery dv/dt ⑤	5.5	V/ns
T <sub>J</sub>	Operating Junction and	-55 to + 175	°C
T <sub>STG</sub>	Storage Temperature Range		
	Soldering Temperature, for 10 seconds	300 (1.6mm from case )	

## Thermal Resistance

	Parameter	Typ.	Max.	Units
R <sub>θJC</sub>	Junction-to-Case	—	0.75	°C/W
R <sub>θJA</sub>	Junction-to-Ambient (PCB Mounted, Steady State)**	—	40	

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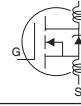
1

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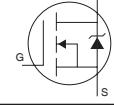
# IRF3808S/LPbF

International  
Rectifier

## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	75	—	—	V	$V_{\text{GS}} = 0\text{V}, I_D = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	0.086	—	$\text{V}^\circ\text{C}$	Reference to $25^\circ\text{C}, I_D = 1\text{mA}$
$R_{\text{DS}(\text{on})}$	Static Drain-to-Source On-Resistance	—	5.9	7.0	$\text{m}\Omega$	$V_{\text{GS}} = 10\text{V}, I_D = 82\text{A}$ ④
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	2.0	—	4.0	V	$V_{\text{DS}} = 10\text{V}, I_D = 250\mu\text{A}$
$g_{\text{fs}}$	Forward Transconductance	100	—	—	S	$V_{\text{DS}} = 25\text{V}, I_D = 82\text{A}$
$I_{\text{DSS}}$	Drain-to-Source Leakage Current	—	—	20	$\mu\text{A}$	$V_{\text{DS}} = 75\text{V}, V_{\text{GS}} = 0\text{V}$
		—	—	250		$V_{\text{DS}} = 60\text{V}, V_{\text{GS}} = 0\text{V}, T_J = 150^\circ\text{C}$
$I_{\text{GSS}}$	Gate-to-Source Forward Leakage	—	—	200	nA	$V_{\text{GS}} = 20\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-200		$V_{\text{GS}} = -20\text{V}$
$Q_g$	Total Gate Charge	—	150	220	nC	$I_D = 82\text{A}$
$Q_{\text{gs}}$	Gate-to-Source Charge	—	31	47		$V_{\text{DS}} = 60\text{V}$
$Q_{\text{gd}}$	Gate-to-Drain ("Miller") Charge	—	50	76		$V_{\text{GS}} = 10\text{V}$ ④
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	—	16	—	ns	$V_{\text{DD}} = 38\text{V}$
$t_r$	Rise Time	—	140	—		$I_D = 82\text{A}$
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	—	68	—		$R_G = 2.5\Omega$
$t_f$	Fall Time	—	120	—		$V_{\text{GS}} = 10\text{V}$ ④
$L_D$	Internal Drain Inductance	—	4.5	—	nH	Between lead, 6mm (0.25in.) from package and center of die contact
$L_S$	Internal Source Inductance	—	7.5	—		
$C_{\text{iss}}$	Input Capacitance	—	5310	—	pF	$V_{\text{GS}} = 0\text{V}$
$C_{\text{oss}}$	Output Capacitance	—	890	—		$V_{\text{DS}} = 25\text{V}$
$C_{\text{rss}}$	Reverse Transfer Capacitance	—	130	—		$f = 1.0\text{MHz}$ , See Fig. 5
$C_{\text{oss}}$	Output Capacitance	—	6010	—		$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 1.0\text{V}, f = 1.0\text{MHz}$
$C_{\text{oss}}$	Output Capacitance	—	570	—		$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 60\text{V}, f = 1.0\text{MHz}$
$C_{\text{oss eff.}}$	Effective Output Capacitance ④	—	1140	—		$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 0\text{V to } 60\text{V}$

## Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	106⑥	A	MOSFET symbol showing the integral reverse p-n junction diode.
$I_{\text{SM}}$	Pulsed Source Current (Body Diode) ①	—	—	550		
$V_{\text{SD}}$	Diode Forward Voltage	—	—	1.3	V	$T_J = 25^\circ\text{C}, I_S = 82\text{A}, V_{\text{GS}} = 0\text{V}$ ④
$t_{\text{rr}}$	Reverse Recovery Time	—	93	140	ns	$T_J = 25^\circ\text{C}, I_F = 82\text{A}$
$Q_{\text{rr}}$	Reverse Recovery Charge	—	340	510	nC	$dI/dt = 100\text{A}/\mu\text{s}$ ④
$t_{\text{on}}$	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$ )				

### Notes:

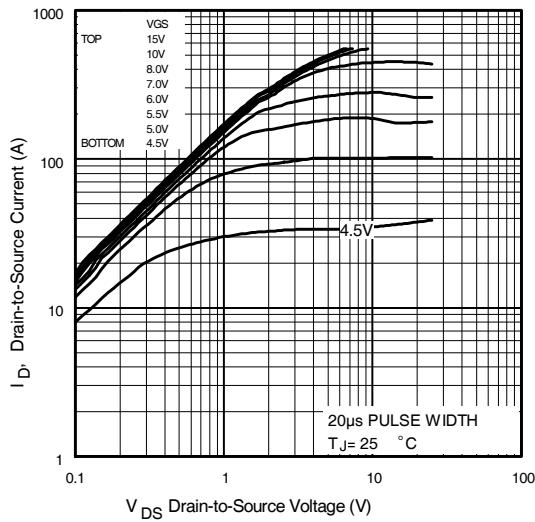
- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11).
- ② Starting  $T_J = 25^\circ\text{C}$ ,  $L = 0.130\text{mH}$   
 $R_G = 25\Omega$ ,  $I_{AS} = 82\text{A}$ . (See Figure 12).
- ③  $I_{SD} \leq 82\text{A}$ ,  $di/dt \leq 310\text{A}/\mu\text{s}$ ,  $V_{\text{DD}} \leq V_{(\text{BR})\text{DSS}}$ ,  
 $T_J \leq 175^\circ\text{C}$
- ④ Pulse width  $\leq 400\mu\text{s}$ ; duty cycle  $\leq 2\%$ .

⑤  $C_{\text{oss eff.}}$  is a fixed capacitance that gives the same charging time as  $C_{\text{oss}}$  while  $V_{\text{DS}}$  is rising from 0 to 80%  $V_{\text{DS}}$ .

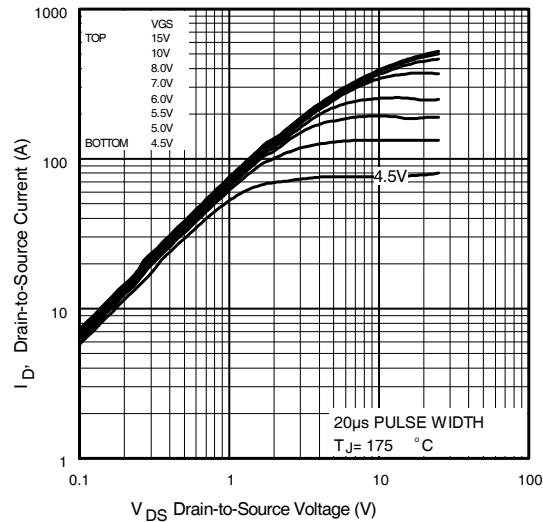
⑥ Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 75A.

⑦ Limited by  $T_{J\text{max}}$ , see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.

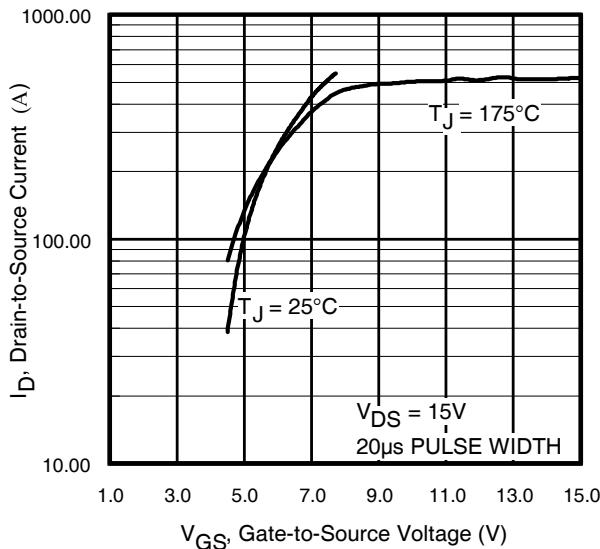
\*\* When mounted on 1" square PCB ( FR-4 or G-10 Material ).  
For recommended footprint and soldering techniques refer to application note #AN-994.



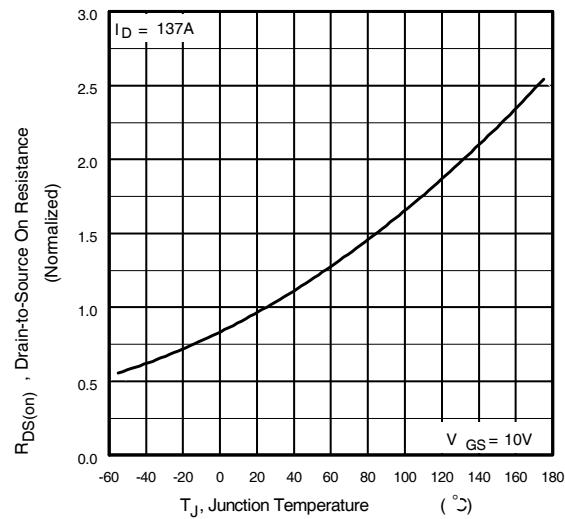
**Fig 1.** Typical Output Characteristics



**Fig 2.** Typical Output Characteristics



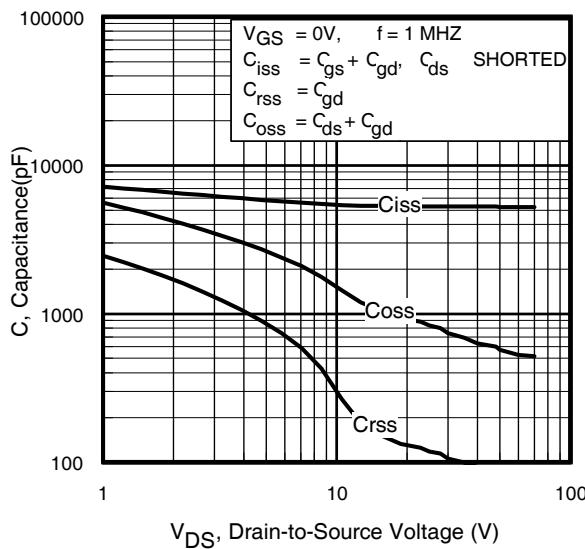
**Fig 3.** Typical Transfer Characteristics



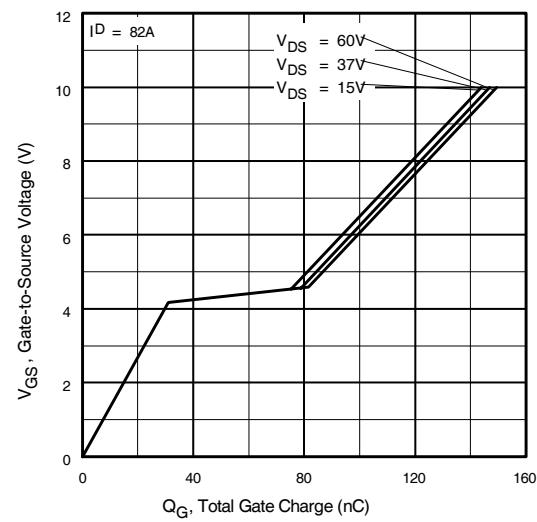
**Fig 4.** Normalized On-Resistance  
Vs. Temperature

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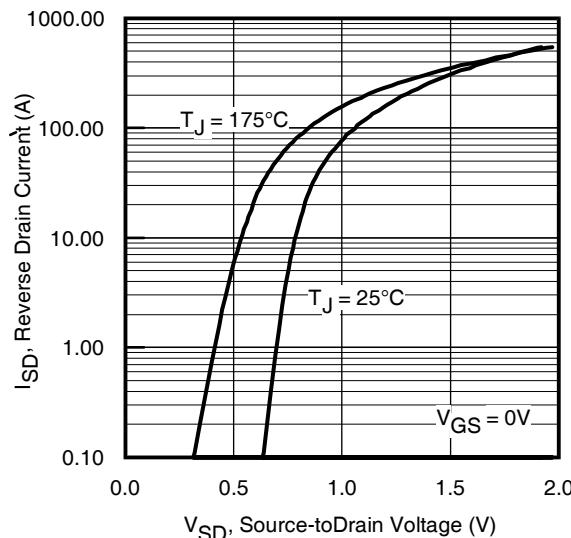
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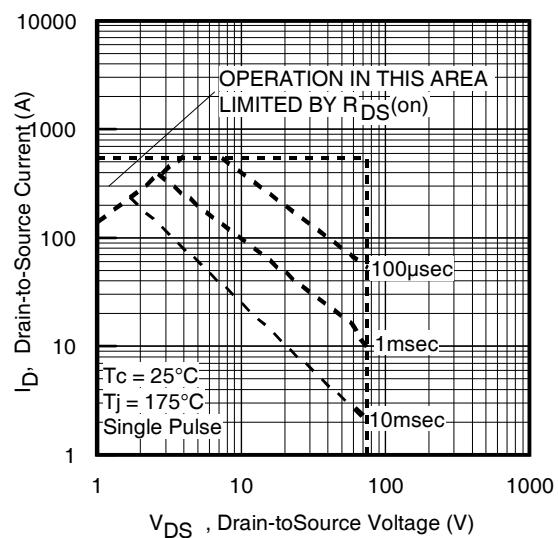
**Fig 5.** Typical Capacitance Vs.  
Drain-to-Source Voltage



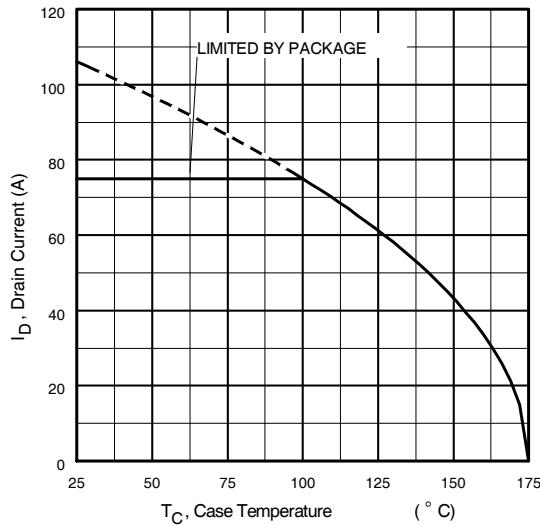
**Fig 6.** Typical Gate Charge Vs.  
Gate-to-Source Voltage



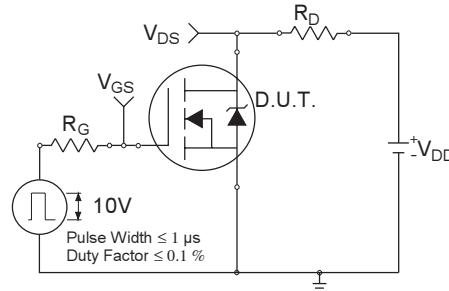
**Fig 7.** Typical Source-Drain Diode  
Forward Voltage



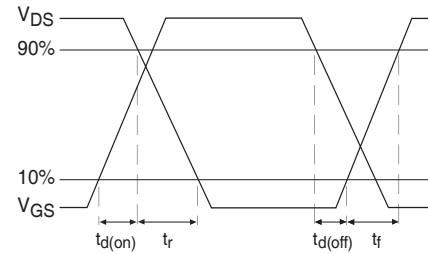
**Fig 8.** Maximum Safe Operating Area



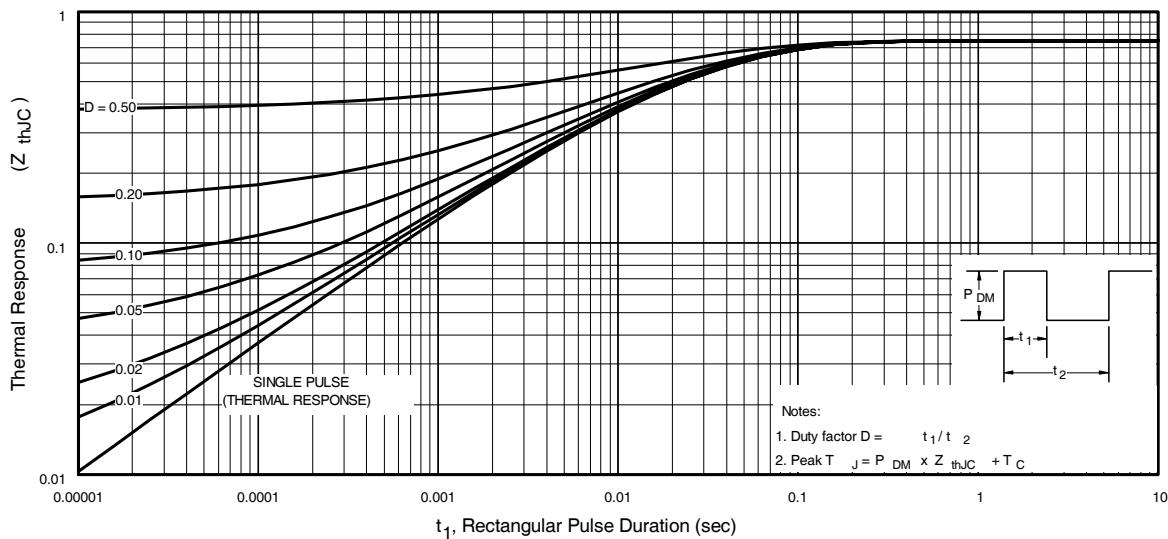
**Fig 9.** Maximum Drain Current Vs.  
Case Temperature



**Fig 10a.** Switching Time Test Circuit



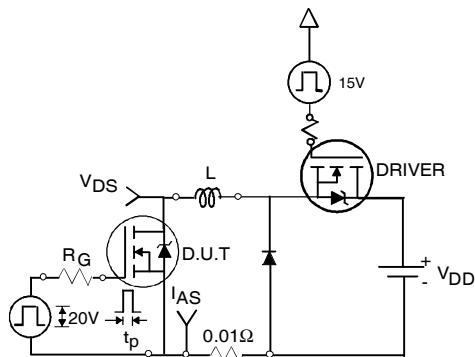
**Fig 10b.** Switching Time Waveforms



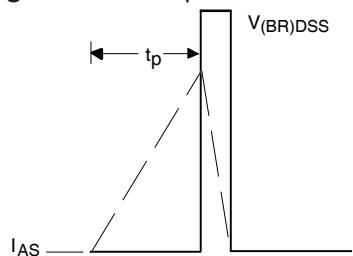
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

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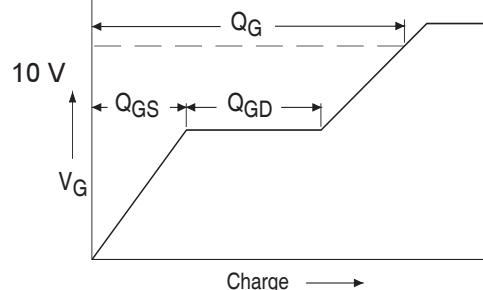
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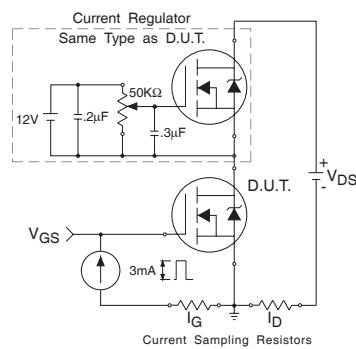
**Fig 12a.** Unclamped Inductive Test Circuit



**Fig 12b.** Unclamped Inductive Waveforms

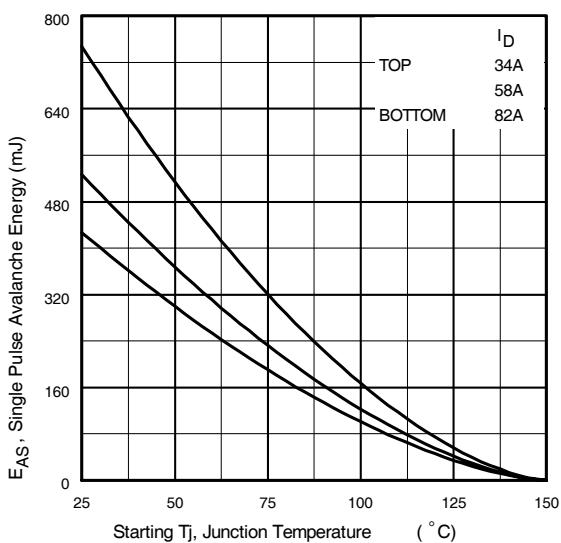


**Fig 13a.** Basic Gate Charge Waveform

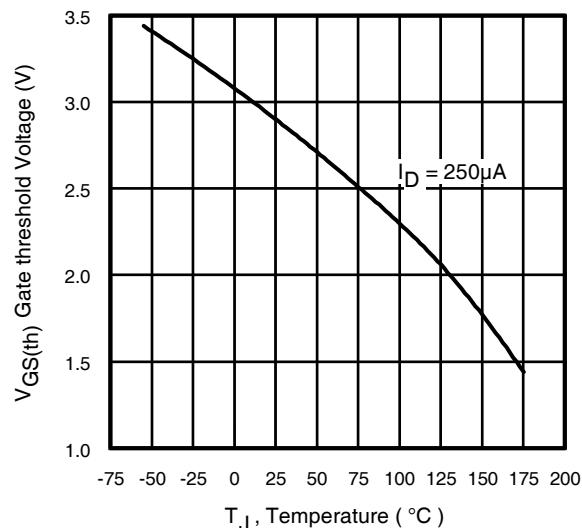


**Fig 13b.** Gate Charge Test Circuit

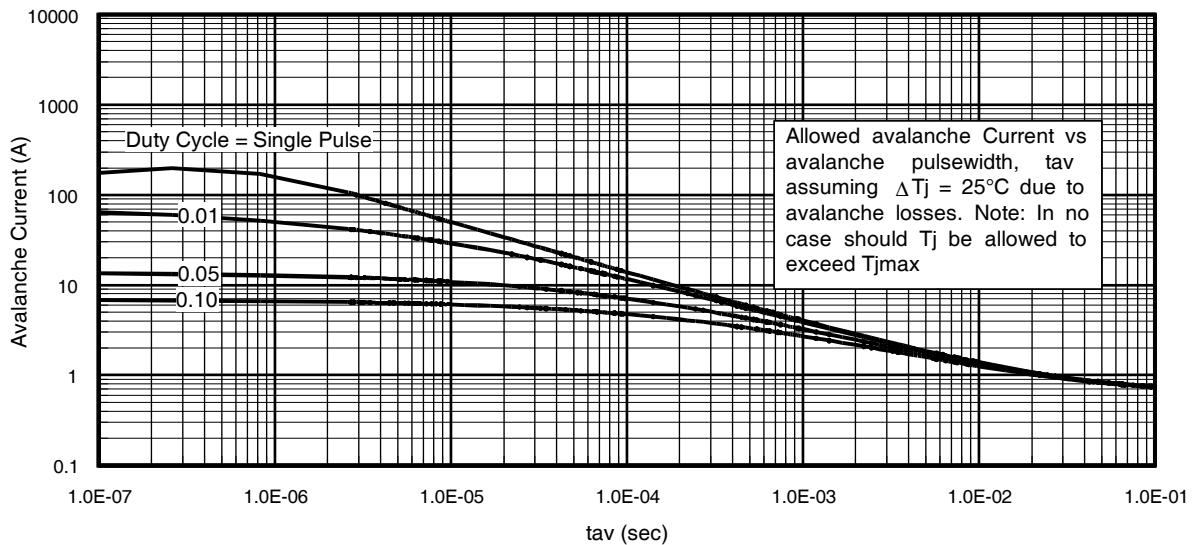
6



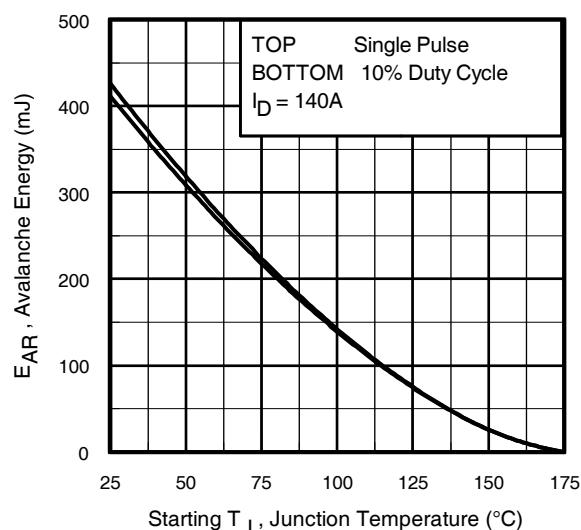
**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current



**Fig 14.** Threshold Voltage Vs. Temperature  
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**Fig 15.** Typical Avalanche Current Vs.Pulsewidth



**Fig 16.** Maximum Avalanche Energy Vs. Temperature

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**Notes on Repetitive Avalanche Curves , Figures 15, 16:**  
**(For further info, see AN-1005 at [www.irf.com](http://www.irf.com))**

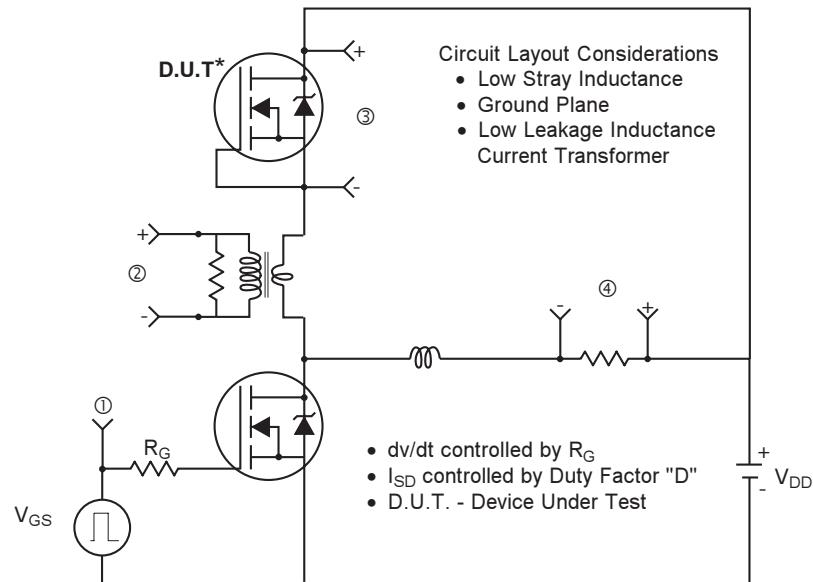
1. Avalanche failures assumption:  
Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.
2. Safe operation in Avalanche is allowed as long as  $T_{jmax}$  is not exceeded.
3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
4.  $P_{D(\text{ave})}$  = Average power dissipation per single avalanche pulse.
5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
6.  $I_{av}$  = Allowable avalanche current.
7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as  $25^\circ\text{C}$  in Figure 15, 16).  
 $t_{av}$  = Average time in avalanche.  
 $D$  = Duty cycle in avalanche =  $t_{av} \cdot f$   
 $Z_{thJC}(D, t_{av})$  = Transient thermal resistance, see figure 11)

$$P_{D(\text{ave})} = 1/2 (1.3 \cdot BV \cdot I_{av}) = \Delta T / Z_{thJC}$$

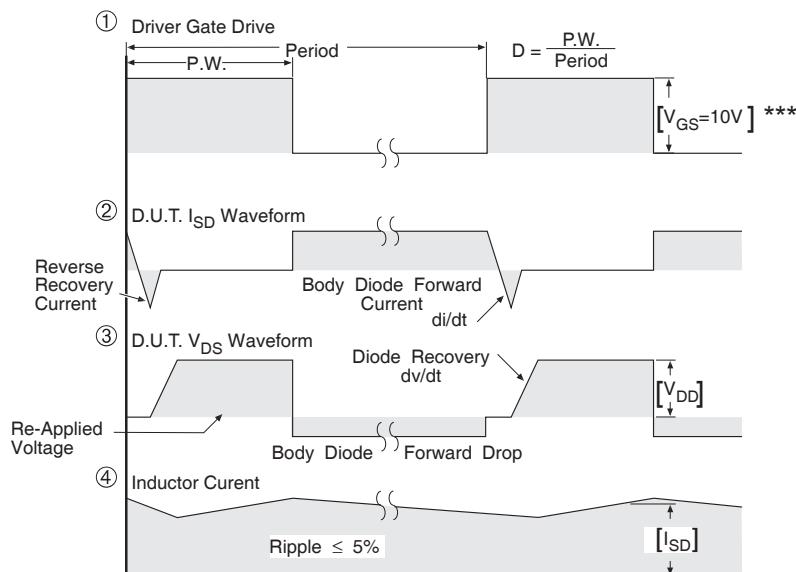
$$I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$$

$$E_{AS(AR)} = P_{D(\text{ave})} \cdot t_{av}$$

## Peak Diode Recovery dv/dt Test Circuit



\* Reverse Polarity of D.U.T for P-Channel

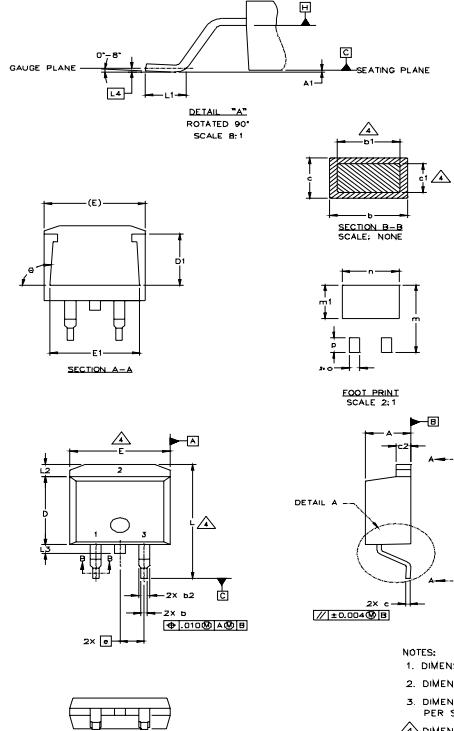


\*\*\*  $V_{GS} = 5.0V$  for Logic Level and 3V Drive Devices

**Fig 17.** For N-channel HEXFET® power MOSFETs

## D<sup>2</sup>Pak Package Outline

Dimensions are shown in millimeters (inches)



SYM BO L	DIMENSIONS		NOTE S	
	MILLIMETERS			
	MIN.	MAX.		
A	4.06	4.83	.160 .190	
A1	0.51	0.127	.020 .039	
b	0.51	0.99	.020 .035	
b1	0.51	0.89	.045 .055	
b2	1.14	1.40	.055	
c	0.43	0.63	.017 .025	
c1	0.38	0.74	.015 .029	
c2	1.14	1.40	.045 .055	
D	8.51	9.65	.335 .380	
D1	5.33		.210	
E	9.65	10.67	.380 .420	
E1	6.22		.245	
e	2.54	BSC	.100 BSC	
L	14.61	15.88	.575 .625	
L1	1.78	2.79	.070 .110	
L2		1.65	.065	
L3	1.27	1.78	.050 .070	
L4	0.25	BSC	.010 BSC	
m	17.78		.700	
m1	8.89		.350	
n	11.43		.450	
o	2.08		.082	
p	3.81		.150	
θ	90°	93°	90° 93°	

### LEAD ASSIGNMENTS

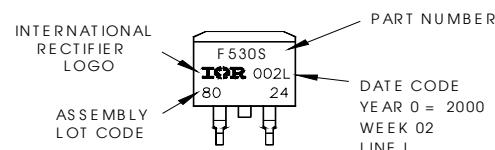
HEXFET	IGBT <sub>3</sub> , CoPACK	DIODES
1.- GATE 2.- DRAIN 3.- SOURCE	1.- GATE 2.- COLLECTOR 3.- Emitter	1.- ANODE * 2.- CATHODE 3.- ANODE

\* PART DEPENDENT.

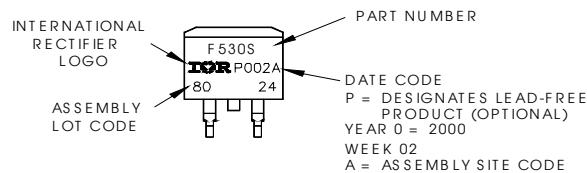
## D<sup>2</sup>Pak Part Marking Information (Lead-Free)

EXAMPLE: THIS IS AN IRF530S WITH  
 LOT CODE 8024  
 ASSEMBLED ON WW 02, 2000  
 IN THE ASSEMBLY LINE "L"

Note: "P" in assembly line  
 position indicates "Lead-Free"



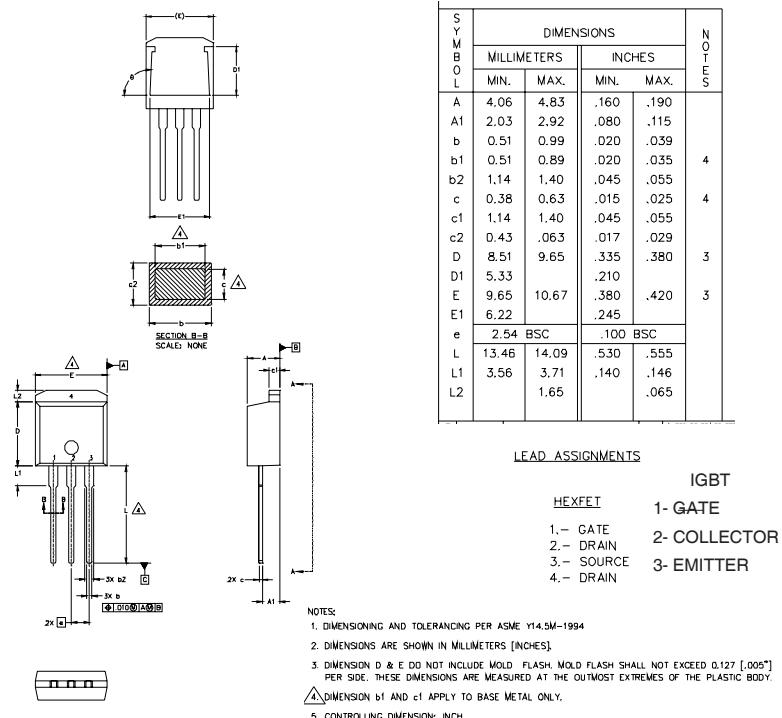
OR



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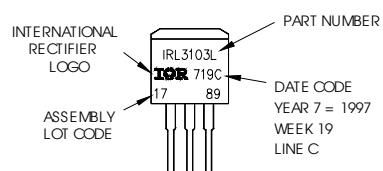
## TO-262 Package Outline



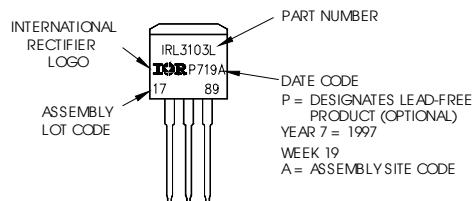
## TO-262 Part Marking Information

EXAMPLE: THIS IS AN IRL3103L  
LOT CODE 1789  
ASSEMBLED ON WW 19, 1997  
IN THE ASSEMBLY LINE "C"

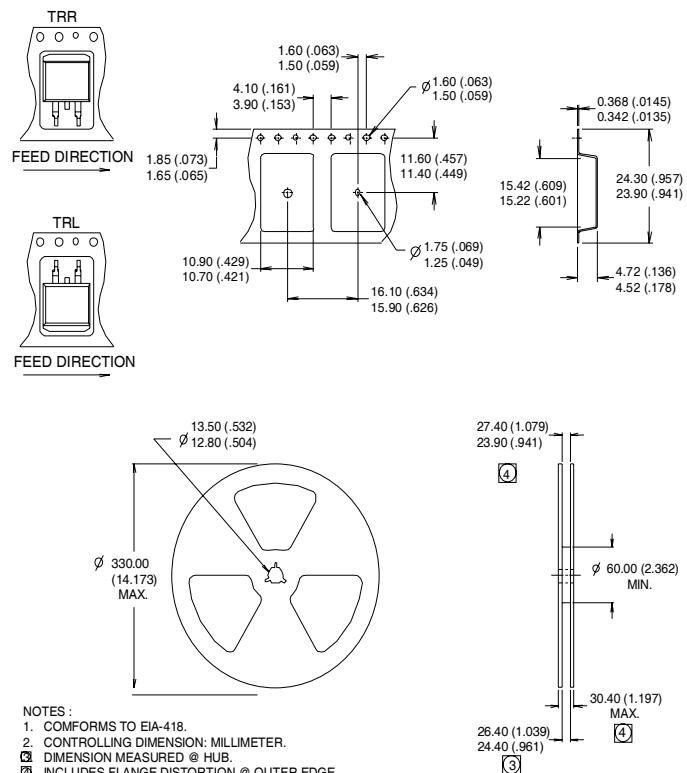
Note: "P" in assembly line  
position indicates "Lead-Free"



OR



**D<sup>2</sup>Pak Tape & Reel Infomation**  
 Dimensions are shown in millimeters (inches)



Data and specifications subject to change without notice.  
 This product has been designed and qualified for the Industrial market.  
 Qualification Standards can be found on IR's Web site.

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**IR** Rectifier

**IR WORLD HEADQUARTERS:** 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105  
 TAC Fax: (310) 252-7903  
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